

OFFICE OF THE DEPUTY PRINCIPAL ACADEMICS, STUDENT AFFAIRS AND RESEARCH

UNIVERSITY EXAMINATIONS **2019 /2020 ACADEMIC YEAR**

THIRD YEAR SECOND SEMESTER EXAMINATION

FOR THE DEGREE OF BACHELOR OF **COMPUTER SCIENCE**

MAIN EXAMINATION

COURSE CODE:

COM 324 E

COURSE TITLE: MICROELECTRONICS

DATE: 2ND NOVEMBER, 2020

TIME: 9.00 AM - 12.00 NOON

INSTRUCTION TO CANDIDATES

SEE INSIDE

THIS PAPER CONSISTS OF PRINTED PAGES

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REGULAR - MAIN EXAM

COM 324 E: MICROELECTRONICS

STREAM: BSc (Computer Science)

DURATION: 3 Hours

INSTRUCTIONS TO CANDIDATES

- i. Answer ALL questions from section A and any THREE from section B.
- ii. Maps and diagrams should be used whenever they serve to illustrate the answer.
- iii. Do not write on the question paper.

SECTION A (24 MARKS) COMPULSORY

QUESTION ONE [12 MARKS]

a. Define photolithography process. [2 Marks]
b. Define the term diffusion [2 marks]
c. Describe how residual solvents of the photoresist are removed. [2 Marks]
d. With the aid of a diagram, explain how positive photoresist is achieved. [3 Marks]

e. Elaborate how atomic diffusion is performed to ensure that the electrical properties of the silicon atoms are altered to enable the creation of electrical devices on a wafer. [3 marks]

QUESTION TWO [12 MARKS]

- a. Explain why hotplate prebaking is preferred to conventional oven prebaking. [2 Marks]
- b. Explain a situation which calls for use of electron beam lithography despite it being slow and more expensive compared to other lithography methods. [2 Marks]
- c. Describe how grounding is achieved in electron beam lithography process. [2 Marks]

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d.	Explain why magnetic lenses are preferred to electrostatic lenses for focusing electrons is			
	electron beam lithography.	[2 Marks]		
e.	Explain the difference between dry etching and wet etching.	[4 Marks]		
	SECTION B [36 MARKS]			
	QUESTION THREE [12 MARKS]			
a.	Explain why ion implantation has largely displaced diffusion when it con	nes to doping in		
	modern semiconductor manufacturing.	[2 Marks]		
b.	Explain the consequence of refilling a wrong photoresist in the spinner.	[3 Marks]		
c.	Despite being preferred over atomic diffusion, ion implantation damages the silico			
	lattice. Explain how this drawback is corrected.	[3 Marks]		
d.	Explain how photolithography and analog-photography are similar.	[4 Marks]		
QUESTION FOUR [12 MARKS]				
a.	List the three major process steps used in photolithography	[3 Marks]		
b.	Despite ultraviolet light being one of the techniques used in lithography, it is not used for			
	very large scale integrated circuit development. Outline the techniques through which			
	lithography can take place for very large scale integrated circuit development. [3 Marks]			
c.	With the aid of diagrams, explain the two primary techniques for pattern	ing additive and		
	subtractive photolithography.	[6 Marks]		

QUESTION FIVE [12 MARKS]

a.	Define the term Streaks with respect to photolithography	[2 Marks]	
b.	State the type of metal which is preferred for metallization and the p	properties which	
	makes it suitable.	[5 Marks]	
c.	With the aid of a diagram, describe how electron beam lithography process	ss is achieved.	
		[5 Marks]	
QUESTION SIX [12 MARKS]			
a.	Define the following terms with respect to microelectronics:		
	i. Polymerization	[2 Marks]	
j	ii. Photo-solubilization	[2 Marks]	
b.	Explain why lithography is essential in microelectronics.	[2 Marks]	
c.	Describe the main parameters which are inspected after developing a r	nicro-electronic	
	device using lithography process.	[6 Marks]	
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